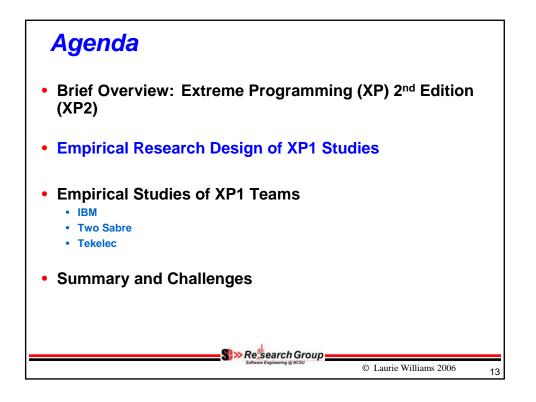
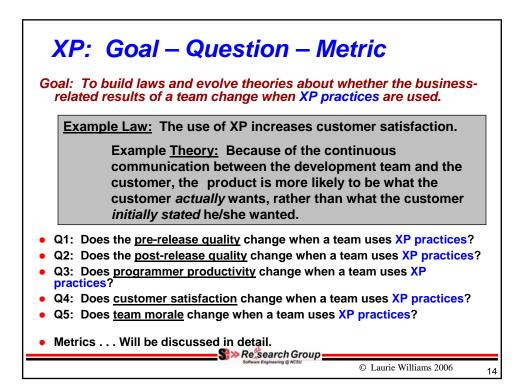
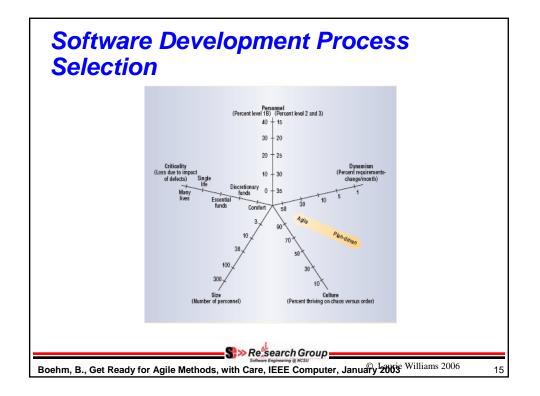


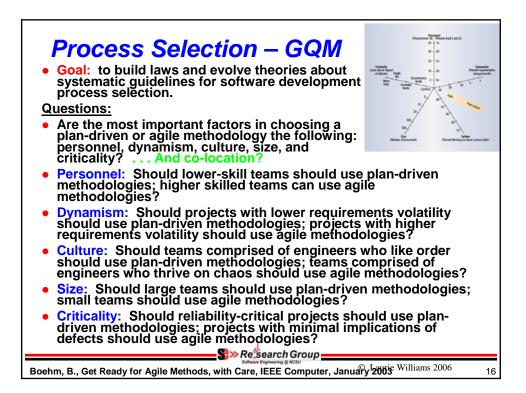
XP2 Primary Practice Summary

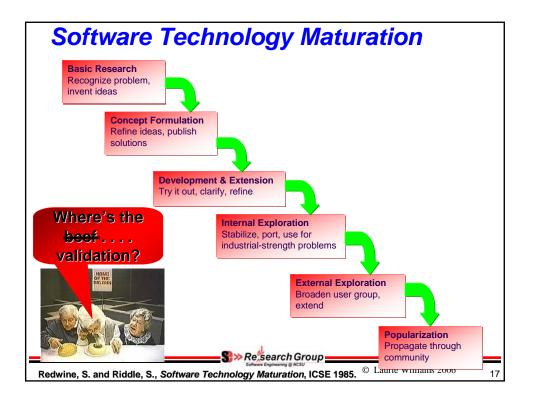
nary Practice	Sustained/New/ XP1 Name	XP1 Practice	Disposition	
hor	New	Metaphor	Removed	
ther		Collective code	Corollary: Shared	
team	New	ownership	code	
ative workspace	New			
gized work	40-hour week	On-site customer	Corollary: Real	
programming	Sustained		involvement	
es	Planning game	Coding standard	Removed	
kly cycle	Planning game			
rterly cycle	Small releases			
<	New			
minute build	New			
inuous integration	Sustained			
-first Programming	Testing			
mental Design	Simple Design Refactoring			
	S > R	essearch Group		
	Sof	tware Engineering @ NCSU	© Laurie Williams 2006	

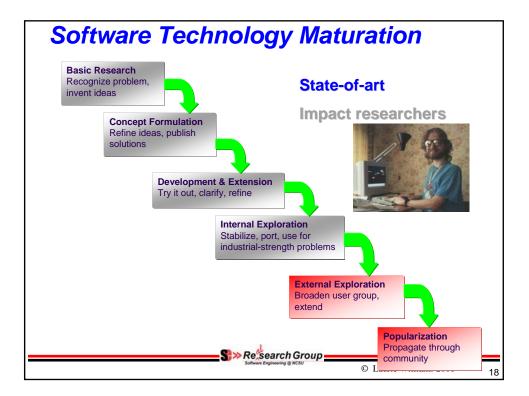


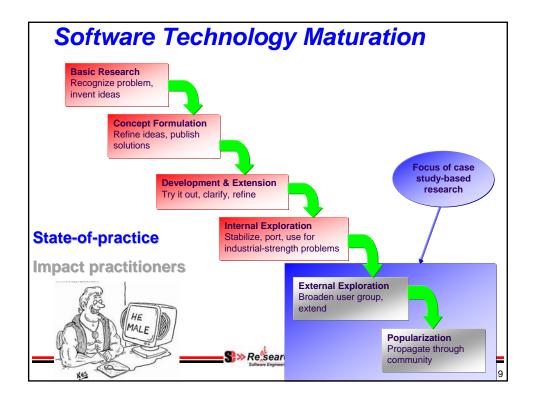


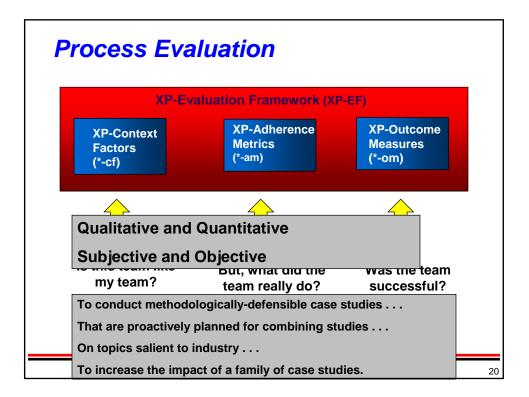


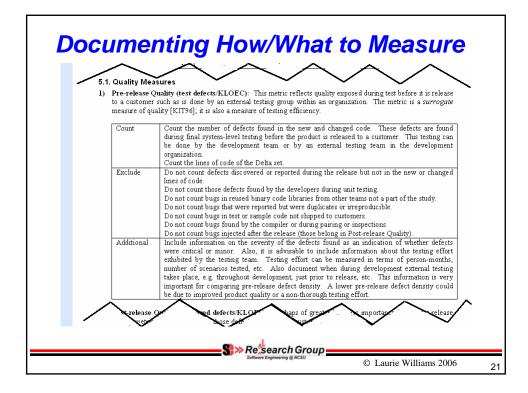


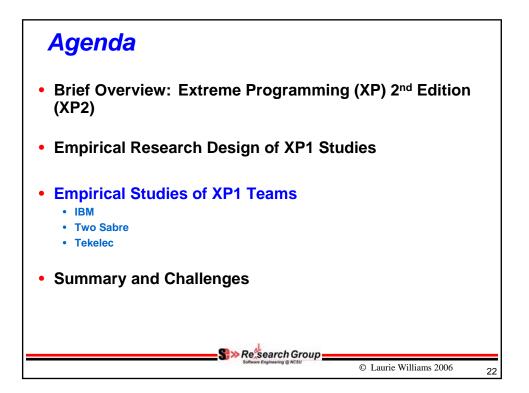


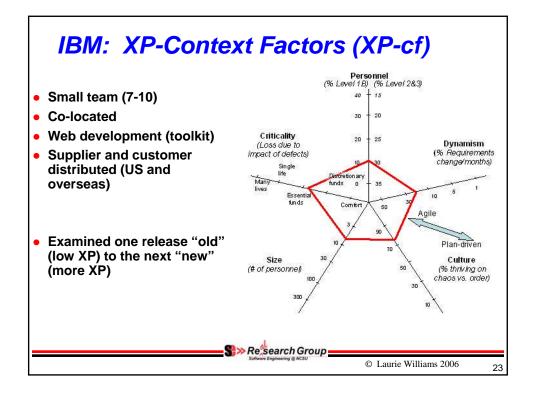






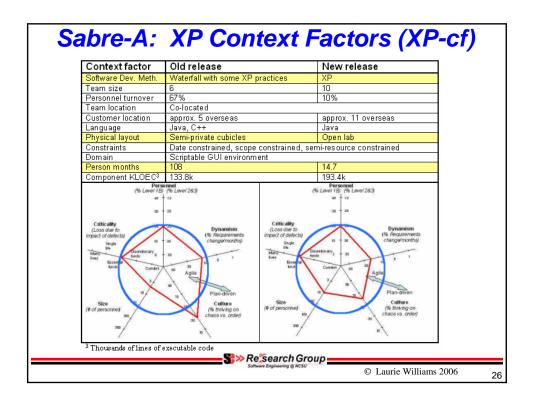






 IBM: XP-Adf Subjective: Shodan Surv Example survey at: http://a Old 56% New 72% Objective Metrics 			
XP-am Metric	Practice	Old	New
Automated test class per user story	Testing	0.11	0.45
Test coverage (statement)	Testing	30%	46%
Unit test runs per person day	Testing	14%	11%
Test LOC/Source LOC	Testing	0.26	0.42
Accept test execute	Testing	Manual	Manual
Did customers run your acceptance tests?	Testing	No	No
Pairing Frequency	Pair Programming	<5%	48%
Release Length	Short Release	10 months	5 months
Iteration Length	Short Release	Weekly	Weekly
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XP Outcome Measures	Old	New	
Response to Customer Change (Ratio (user stories in + out) /total)	NA	0.23	
Pre-release Quality (test defects/KLOEC of code)	1.0	0.50	
Post-release Quality (released defects/KLOEC of code)	1.0	0.61	
Productivity (stories / PM) Relative KLOEC / PM Putnam Product. Parameter	1.0 1.0 1.0	1.34 1.70 1.92	
Customer Satisfaction	NA	High (qualitative)	
Morale (via survey)	1.0	1.11	

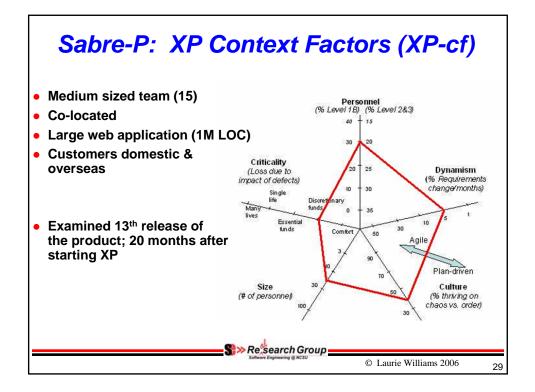


dherence ^{rvey}	Metric	s (XP-am
Practice	Old	New
Testing	0.036	0.572
Testing	N/A	32.9%
Testing	0	1.0
Testing	0.054	0.296
Testing	Manual	Manual
Testing	No	No
Pair Programming	<0%	50%
Short Release	18 months	3.5 months
Short Release		10 days
	rvey Practice Testing Testing Testing Testing Testing Testing Testing Pair Programming	PracticeOldTesting0.036TestingN/ATesting0Testing0.054TestingManualTestingNoPair Programming<0%

Sabre-A: XP-Outcome Measures (XP-om)

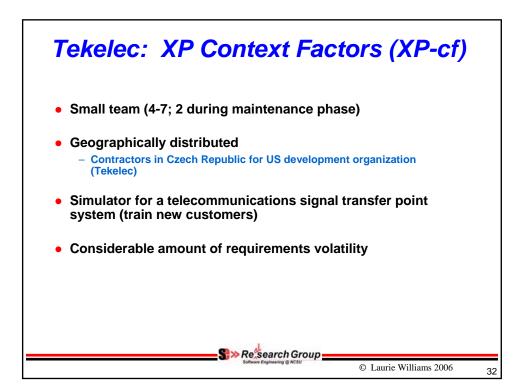
Normalized values

XP Outcome Measures	Old	New
Response to Customer Change (Ratio (user stories in + out) /total)	NA	N/A
Pre-release Quality (test defects/KLOEC of code)	1.0	0.35
Post-release Quality (released defects/KLOEC of code)	1.0	0.70
Productivity (stories / PM) Relative KLOEC / PM Putnam Product. Parameter	N/A 1.0 1.0	N/A 1.46 2.89
Customer Satisfaction	NA	High (anecdotal)
Morale (via survey)	N/A	68.1%



 Subjective: Shodan Surv - 70.2 Objective Metrics 	rey	
XP-am Metric	Practice	New
Automated test class per new/changed class	Testing	0.0225
Test coverage (statement)	Testing	7.7%
Unit test runs per person day	Testing	0.4
Test LOC/Source LOC	Testing	0.296
Pair programming	Pair programming	70%
Release Length	Short Release	3 months
Iteration Length	Short Release	10 days

XP Outcome Measures	Bangalore SPIN Benchmarking group	Capers Jones
Pre-release defect density	Similar	Lower
Total defect density	Lower	Lower
Productivity	Similar	Higher

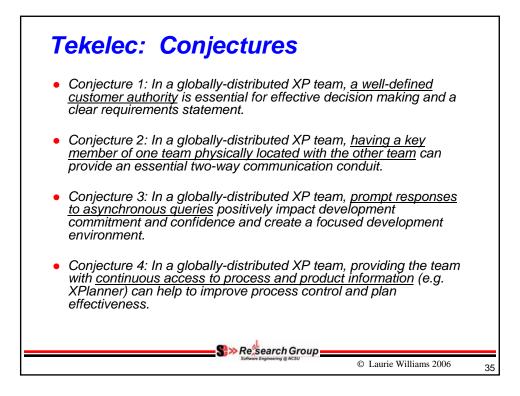


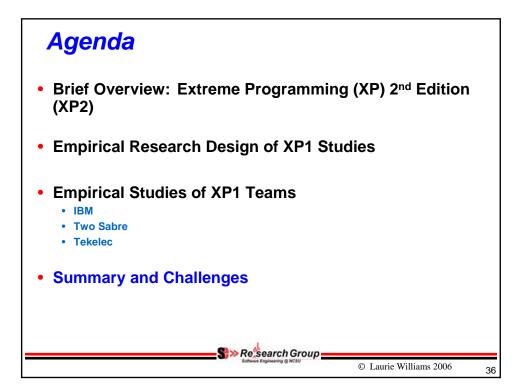
Tekelec: XP-Adherence Metrics (x	KP-am)
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XP-am Metric	Practice	New
Automated test class per new/changed class	Testing	1.0
Test coverage (statement)	Testing	N/A
Unit test runs per person day	Testing	1/day for all; 1/hour for quickset
Test LOC/Source LOC	Testing	0.91
Pair programming	Pair programming	77.5%
Release Length	Short Release	4 months
Iteration Length	Short Release	10 days
	e search Group	

Tekelec: XP-Outcome Measures

Outcome measure	F-15 project
Pre-release Quality (test defects/KLOEC)	N/A
Post-release Quality (post-release defects/KLOEC)	1.62 defects/KLOEC [Lower than industry standards]
Customer Satisfaction (interview)	Capability – Neutral Reliability – Satisfied Communication – Very Satisfied
Productivity	1.22 KLOEC/PM [Lower than industry standards]2.32 KLOEC/PM (including test code) [on par with industry standards]
	S >> Ressearch Group
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	IBM	Sabre-A	Sabre-P	Tekelec
Hypothesis	IBM.	Sabre Airline Solutions	Sabre Airline Solutions	TEKELEO
	Small, Co-located	Small, Co-located	Medium, Co-located	Small, Distributed
pre-release quality	Yes	Yes	Similar-Yes	N/A
post-release quality	Yes	Yes	Yes	Yes
programmer productivity	Yes	Yes	Similar-Higher	No
customer satisfaction	Yes	N/A	N/A	Neutral- satisfied
team morale	Yes	N/A	N/A	N/A
Evaluation Framework	1.3	1.2	1.4	1.4

